FORM PTO-1449 (REV. 7-80)				U.S. DEPARTI PATENT AND	MENT OF COMMERCE TRADEMARK OFFICE	ATTY. DOCKET NO.	ľ	SERIAL NO. 66/643, 947				
LIST OF DOCUMENTS CITED BY APP (Use several sheets if necessary)						APPLICANT		EXAMINER: Edwyn LABA				
						H. YOSHIGI et al		GROUP		MWIN	1459	
						August 20, 2003		2876				
U.S. PATENT DOCUMENTS												
* EXAMINER INITIAL		DOCUMENT		DATE	NAME		CL	ASS	SUBCLASS		DATE opriate)	
EZ	AA	5,113,184		05/1992	Katayama							
EZ	AB	5,418,353		05/1995	Katayama et al							
EZ	AC	5,999,713		12/1999	Reiner et al							
22 22	AD	6,045,043		04/2000	Bashan et al							
EZ	ΑE	5,736,728		04/1998	Matsubara							
EZ	AF	6,070,804		06/2000	Goto							
EZ	AG	6,079,622		06/2000	Goto							
22	АН	6,427,065		07/2002	Suga et al					<u> </u>		
	AI											
	AJ											
	AK		·					_				
FOREIGN PATENT DOCUMENTS												
		DOCUMENT		DATE	C	OUNTRY	CL	ASS	SUBCLASS	TRANSI YES	ATION NO	
纪	AL	04-023092		01/27/92	Japan (with En	n (with English abstract)						
EZ	АМ	04-172588		06/19/92	Japan (with En	glish abstract)						
2	AN	10-209782		08/07/98	Japan (with English abstract)							
EZ		10-505932		6/9/98	Japan			_				
	AP											
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)												
	AR		-									
/	AS											
/	٦3											
7	ΑΤ											
EXAMINER Edwh lakaze DATE CONSIDERED 9/4/04												
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with												
ned communication to applicant.												